Notice of References Cited

Application/Control No. 10/561,875	Applicant(s)/Patent Under Reexamination JENSEN ET AL.	
Examiner	Art Unit	
LYDIA EDWARDS	1797	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,529,692	06-1996	Kubler, Hans	210/603
*	В	US-6,660,518	12-2003	Maekawa, Takaaki	435/291.1
*	С	US-4,780,815	10-1988	Shiota, Kenji	711/171
*	D	US-2004/0025715	02-2004	Bonde et al.	99/485
*	Е	US-2003/0121851	07-2003	Lee, John W. JR.	210/603
*	F	US-2003/0062305	04-2003	Khudenko, Boris M.	210/603
*	G	US-2003/0038078	02-2003	Stamper et al.	210/603
*	Н	US-5,707,417	01-1998	Yokoyama et al.	71/10
	1	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON DATENT DOCUMENTS

	NON-PATENT DOCUMENTS		
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)	
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